
2SJ542

Silicon P Channel MOS FET
High Speed Power Switching

HITACHI

ADE-208-591B (Z)

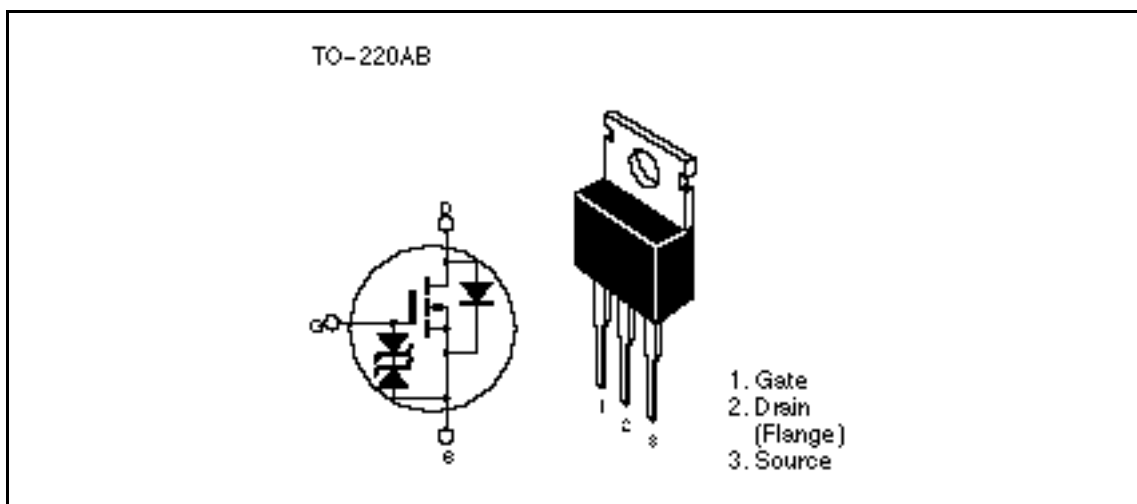
3rd. Edition

Jun 1998

Features

- Low on-resistance
 $R_{DS(on)} = 0.050$ typ.
- Low drive current.
- 4V gate drive devices.
- High speed switching.

Outline



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Absolute Maximum Ratings (Ta = 25°C)

Item	Symbol	Ratings	Unit
Drain to source voltage	V_{DSS}	-60	V
Gate to source voltage	V_{GSS}	± 20	V
Drain current	I_D	-18	A
Drain peak current	$I_{D(pulse)}$ ^{Note1}	-72	A
Body-drain diode reverse drain current	I_{DR}	-18	A
Avalanche current	I_{AP} ^{Note3}	-18	A
Avalanche energy	E_{AR} ^{Note3}	27	mJ
Channel dissipation	P_{ch} ^{Note2}	60	W
Channel temperature	T_{ch}	150	°C
Storage temperature	T_{stg}	-55 to +150	°C

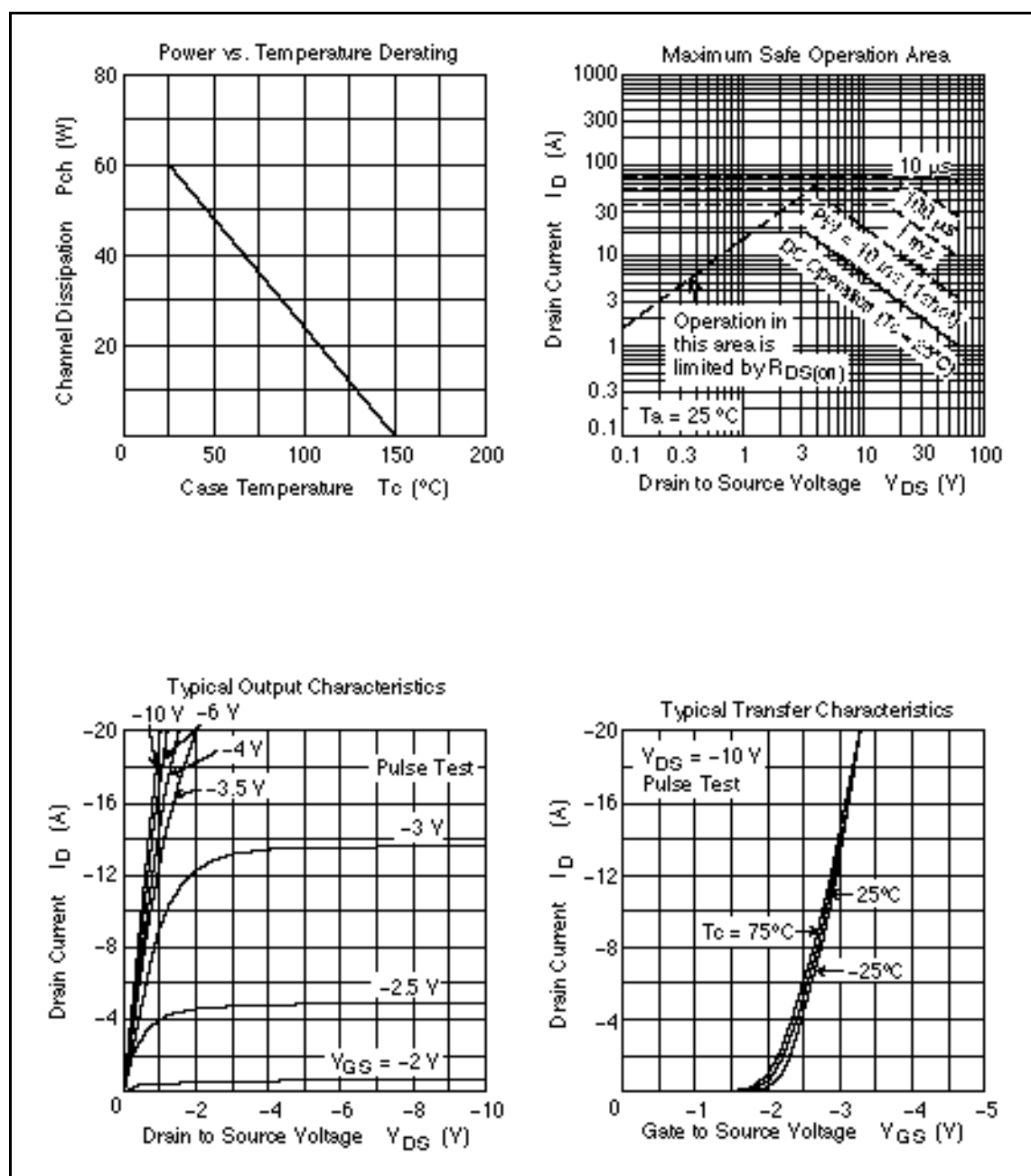
Note: 1. PW 10μs, duty cycle 1 %
 2. Value at Tc = 25°C
 3. Value at Tch = 25°C, Rg 50

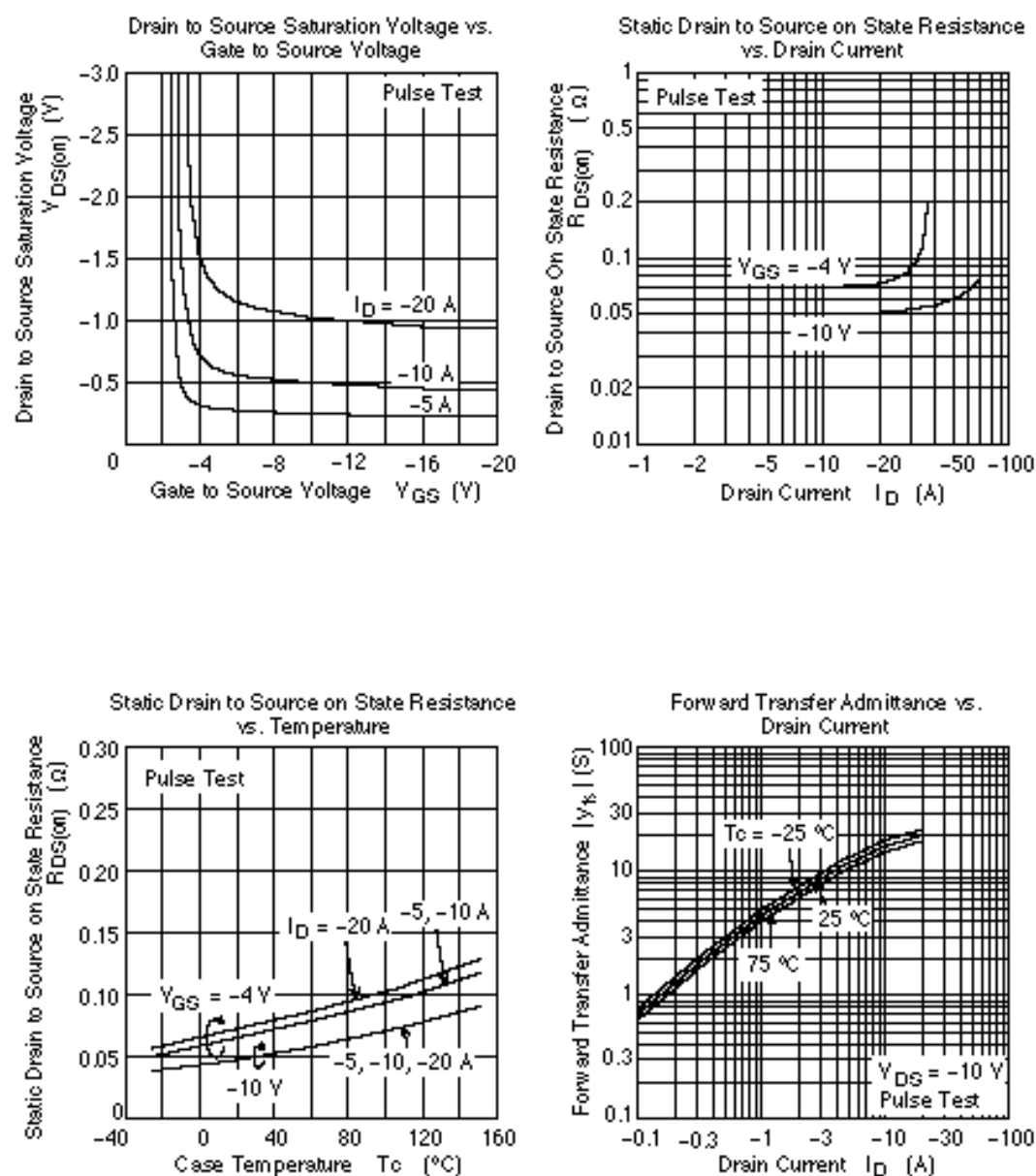
Electrical Characteristics (Ta = 25°C)

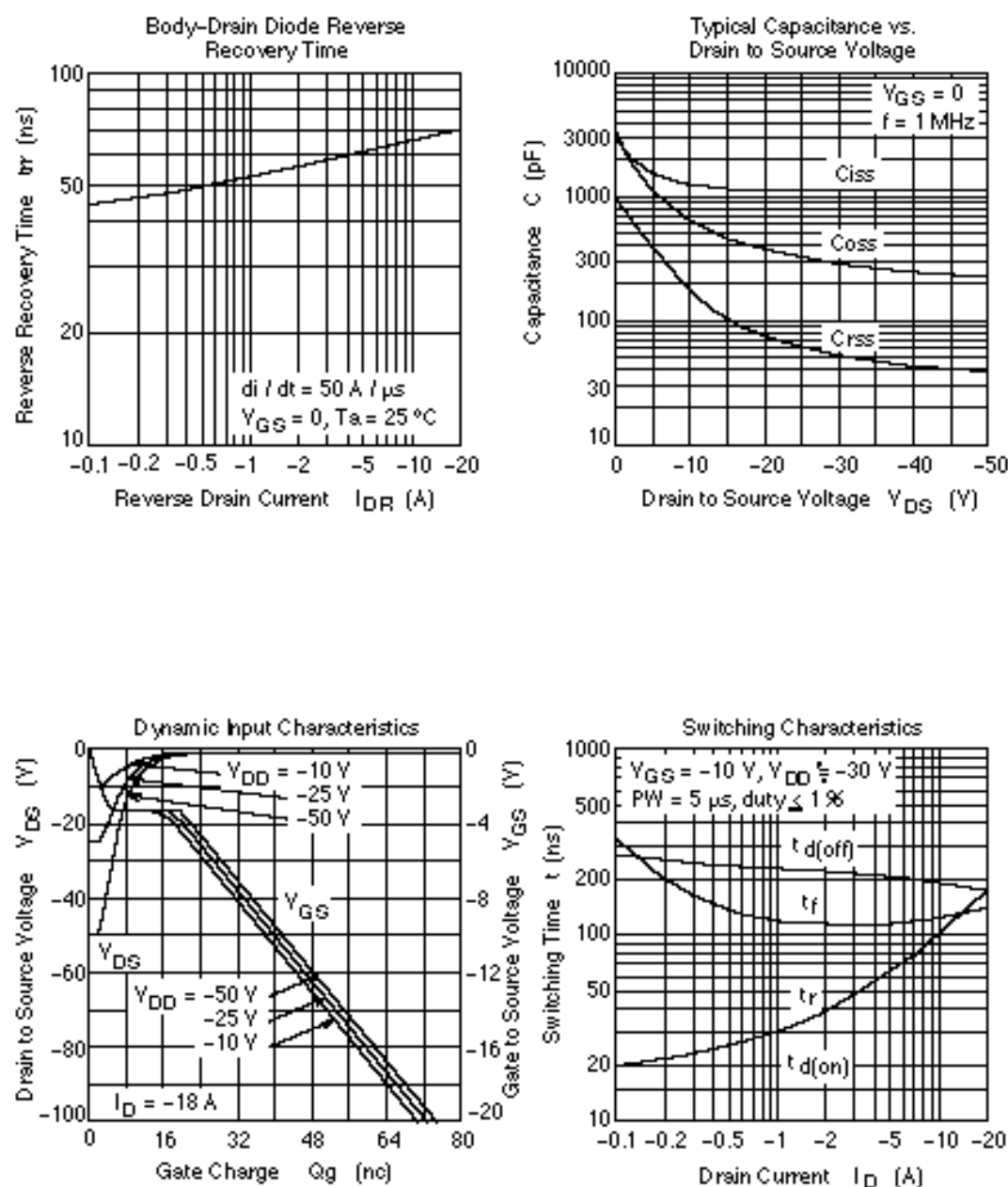
Item	Symbol	Min	Typ	Max	Unit	Test Conditions
Drain to source breakdown voltage	$V_{(BR)DSS}$	-60	—	—	V	$I_D = -10mA, V_{GS} = 0$
Gate to source breakdown voltage	$V_{(BR)GSS}$	± 20	—	—	V	$I_G = \pm 100\mu A, V_{DS} = 0$
Zero gate voltage drain current	I_{DSS}	—	—	-10	μA	$V_{DS} = -60V, V_{GS} = 0$
Gate to source leak current	I_{GSS}	—	—	± 10	μA	$V_{GS} = \pm 16V, V_{DS} = 0$
Gate to source cutoff voltage	$V_{GS(off)}$	-1.0	—	-2.0	V	$I_D = -1mA, V_{DS} = -10V$
Static drain to source on state resistance	$R_{DS(on)}$	—	0.050	0.065		$I_D = -9A, V_{GS} = -10V$ ^{Note4}
	$R_{DS(on)}$	—	0.070	0.110		$I_D = -9A, V_{GS} = -4V$ ^{Note4}
Forward transfer admittance	$ y_{fs} $	10	16	—	S	$I_D = -9A, V_{DS} = -10V$ ^{Note4}
Input capacitance	C_{iss}	—	1300	—	pF	$V_{DS} = -10V$
Output capacitance	C_{oss}	—	650	—	pF	$V_{GS} = 0$
Reverse transfer capacitance	C_{rss}	—	180	—	pF	$f = 1MHz$
Turn-on delay time	$t_{d(on)}$	—	14	—	ns	$V_{GS} = -10V, I_D = -9A$
Rise time	t_r	—	95	—	ns	$R_L = 3.3\Omega$
Turn-off delay time	$t_{d(off)}$	—	190	—	ns	
Fall time	t_f	—	135	—	ns	
Body-drain diode forward voltage	V_{DF}	—	-1.0	—	V	$I_F = -18A, V_{GS} = 0$
Body-drain diode reverse recovery time	t_{rr}	—	70	—	ns	$I_F = -18A, V_{GS} = 0$ $di_F/dt = 50A/\mu s$

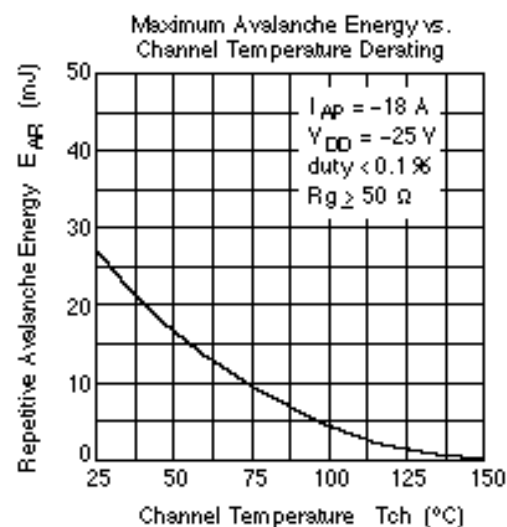
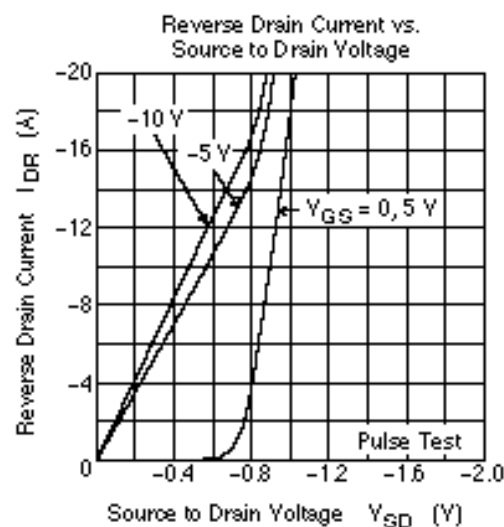
Note: 4. Pulse test

Main Characteristics

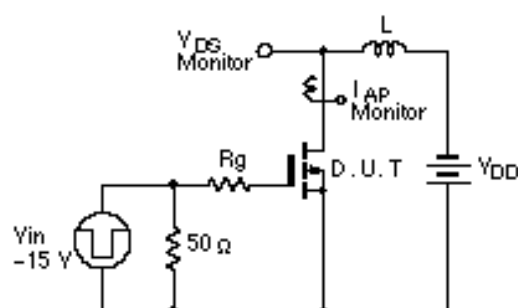




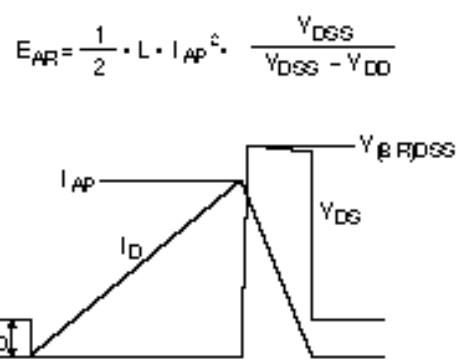


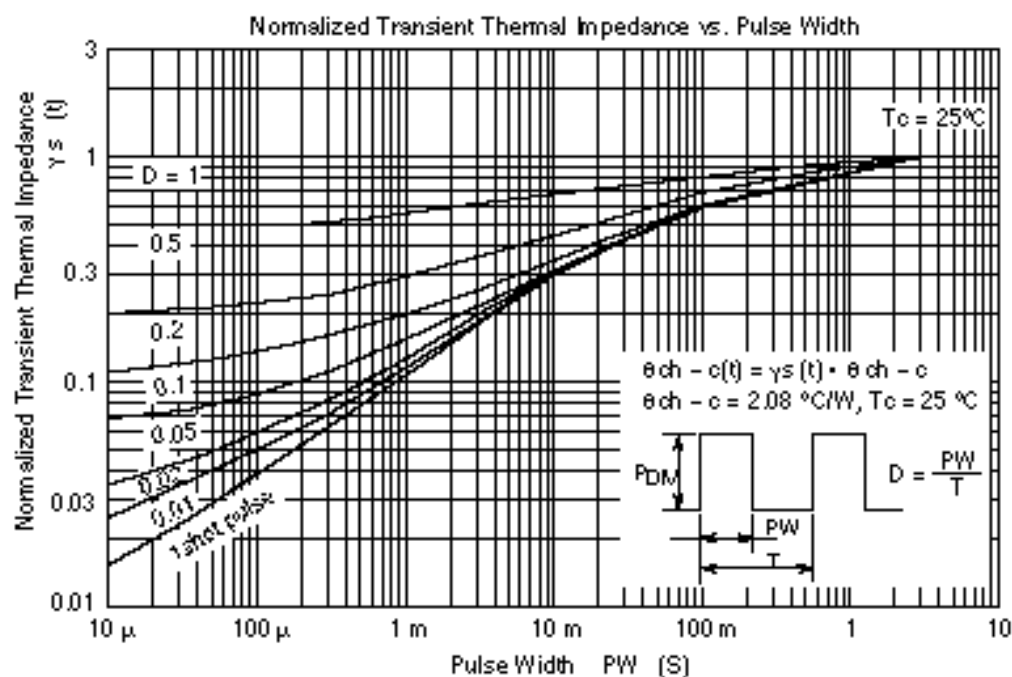


Avalanche Test Circuit

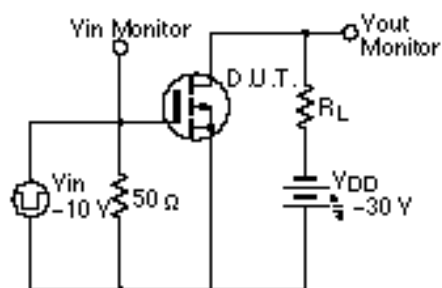


Avalanche Waveform

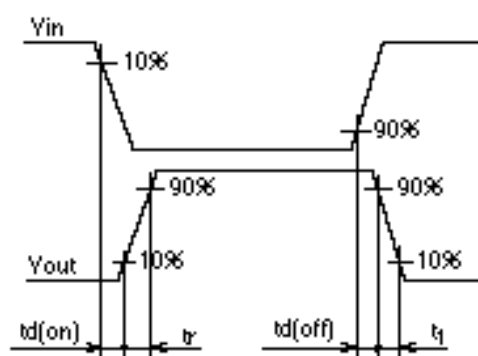




Switching Time Test Circuit



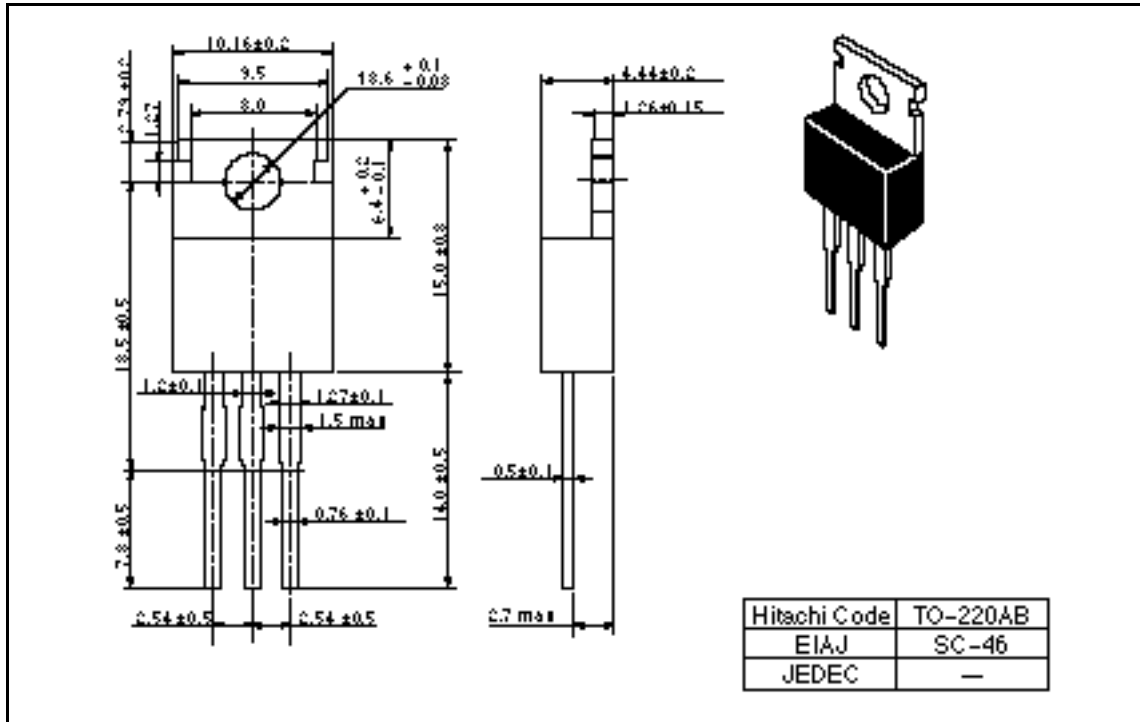
Waveform



2SJ542

Package Dimensions

Unit: mm



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